

Notice of References Cited

Application/Control No.

10/560,783

Applicant(s)/Patent Under

Reexamination

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Examiner

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Art Unit

1791

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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-D507,233	07-2005	Daisho et al.	D12/559
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
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FOREIGN PATENT DOCUMENTS

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